

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74LCX163245FT

16-Bit Dual Supply Bus Transceiver

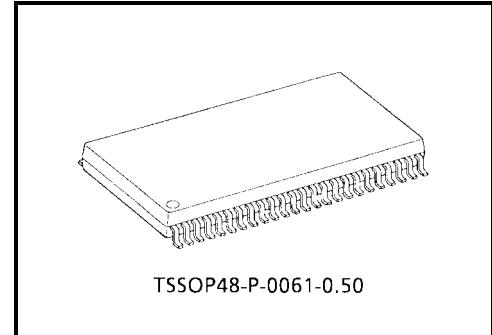
The TC74LCX163245FT is a dual supply, advanced high-speed CMOS 16-bit dual supply voltage interface bus transceiver fabricated with silicon gate CMOS technology.

Designed for use as an interface between a 3.3-V or a 2.5-V bus and a 5-V bus in mixed 3.3-V or 2.5-V/5-V supply systems, it achieves high-speed operation while maintaining the CMOS low power dissipation. It is intended for two-way asynchronous communication between data busses.

The direction of data transmission is determined by the level of the DIR input.

The enable input (\overline{OE}) can be used to disable the device so that the buses are effectively isolated. The B-port interfaces with the 3.3-V or 2.5-V bus, the A-port with the 5 V bus.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.



Weight: 0.25 g (typ.)

Features

- Bidirectional interface between 3.3 V or 2.5 V buses and 5 V buses
- High-speed operation: $t_{pd} = 7.0$ ns (max)
($V_{CCB} = 3.3 \pm 0.3$ V/ $V_{CCA} = 5 \pm 0.5$ V, $T_a = -40$ to 85°C)
- Low power dissipation: $I_{CC} = 80 \mu\text{A}$ (max) ($T_a = -40$ to 85°C)
- Symmetrical output impedance: $I_{OUTB} = \pm 24 \text{ mA}$ (min)
 $I_{OUTA} = \pm 24 \text{ mA}$ (min)
($V_{CCB} = 3.0 \text{ V}/V_{CCA} = 4.5 \text{ V}$)
- Power-down protection provided on all inputs and outputs
- Allows A port and V_{CCA} to float simultaneously in high state at \overline{OE} pin
- Latch-up performance: $\pm 500 \text{ mA}$
- ESD performance: Machine model $> \pm 200 \text{ V}$ (Note 2)
- Package: TSSOP (thin shrink small outline package)

Note 1: Do not apply a signal to any bus pins when it is in the output mode.

Damage may result. All floating (high impedance) bus pins must have their input fixed by means of pull-up or pull-down resistors.

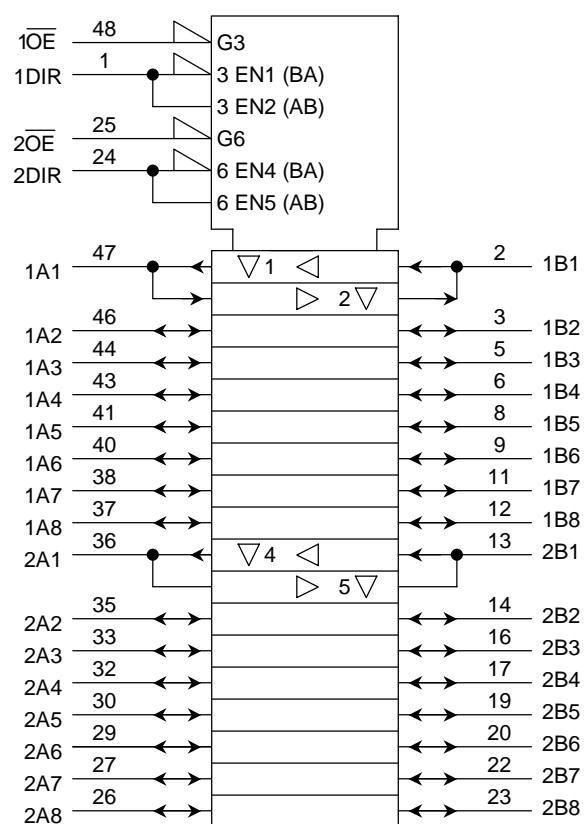
Note 2: This device is electrostatic sensitivity (human body model $> 1 \text{ kV}$).

Please handle with caution.

Pin Assignment (top view)

1DIR	1		48	1OE
1B1	2		47	1A1
1B2	3		46	1A2
GND	4		45	GND
1B3	5		44	1A3
1B4	6		43	1A4
(3.3 V) VCCB	7		42	VCCA (5 V)
1B5	8		41	1A5
1B6	9		40	1A6
GND	10		39	GND
1B7	11		38	1A7
1B8	12		37	1A8
2B1	13		36	2A1
2B2	14		35	2A2
GND	15		34	GND
2B3	16		33	2A3
2B4	17		32	2A4
(3.3 V) VCCB	18		31	VCCA (5 V)
2B5	19		30	2A5
2B6	20		29	2A6
GND	21		28	GND
2B7	22		27	2A7
2B8	23		26	2A8
2DIR	24		25	2OE

IEC Logic Symbol



Truth Table

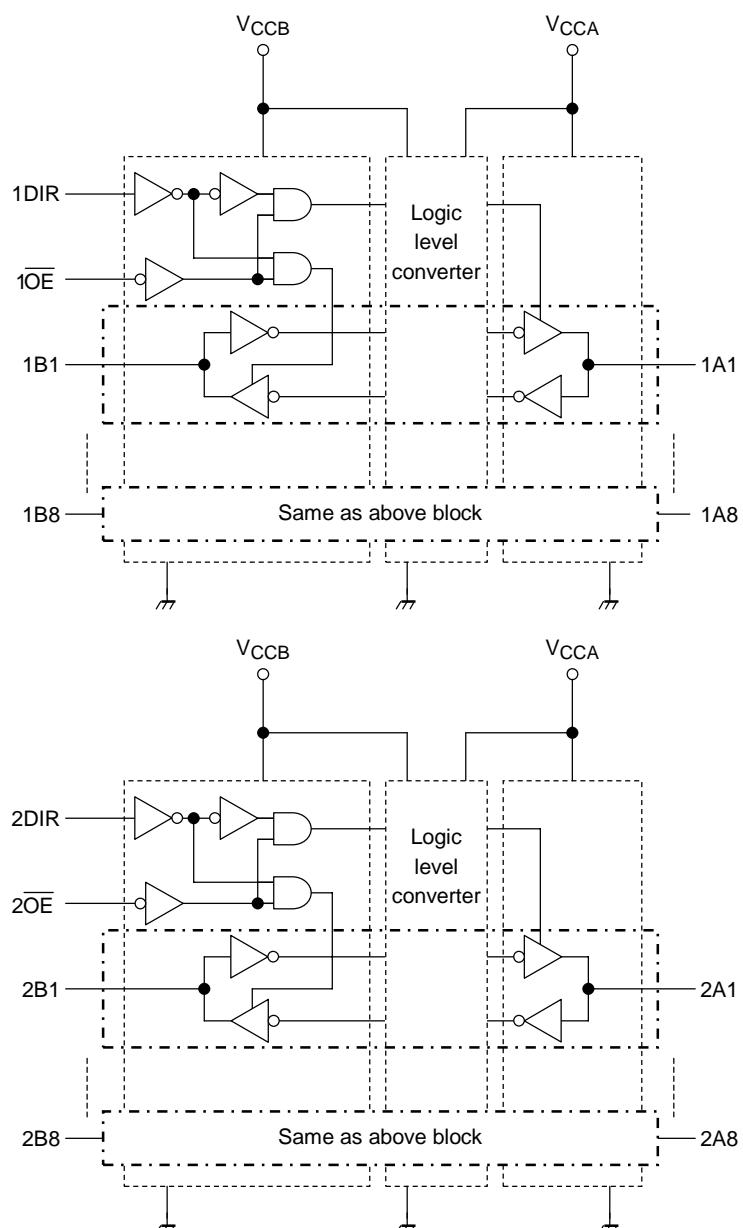
Inputs		Function		Outputs
$\overline{1OE}$	1DIR	Bus 1A1-1A8	Bus 1B1-1B8	
L	L	Output	Input	A = B
L	H	Input	Output	B = A
H	X	Z	Z	Z

Inputs		Function		Outputs
$\overline{2OE}$	2DIR	Bus 2A1-2A8	Bus 2B1-2B8	
L	L	Output	Input	A = B
L	H	Input	Output	B = A
H	X	Z	Z	Z

X: Don't care

Z: High impedance

Block Diagram



Maximum Ratings

Characteristics	Symbol	Rating	Unit
Power supply voltage (Note 3)	V _{CCB}	−0.5 to 7.0	V
	V _{CCA}	−0.5 to 7.0	
DC input voltage (DIR, \overline{OE})	V _{IN}	−0.5 to 7.0	V
DC bus I/O voltage	V _{I/OB}	−0.5 to 7.0 (Note 4)	V
		−0.5 to V _{CCB} + 0.5 (Note 5)	
	V _{I/OA}	−0.5 to 7.0 (Note 4)	
		−0.5 to V _{CCA} + 0.5 (Note 5)	
Input diode current	I _{IK}	−50	mA
Output diode current	I _{I/OK}	±50 (Note 6)	mA
DC output current	I _{OUTB}	±50	mA
	I _{OUTA}	±50	
DC V _{CC} /ground current per supply pin	I _{CCB}	±100	mA
	I _{CCA}	±100	
Power dissipation	P _D	400	mW
Storage temperature	T _{stg}	−65 to 150	°C

Note 3: Don't supply a voltage to V_{CCA} pin when V_{CCB} is in the OFF state.

Note 4: Output in OFF state

Note 5: High or low state. I_{OUT} absolute maximum rating must be observed.

Note 6: V_{OUT} < GND, V_{OUT} > V_{CC}

Recommended Operating Conditions

Characteristics	Symbol	Rating	Unit
Power supply voltage	V _{CCB}	2.3 to 3.6	V
	V _{CCA}	4.5 to 5.5	
Input voltage (DIR, \overline{OE})	V _{IN}	0 to 5.5	V
Bus I/O voltage	V _{I/OB}	0 to 5.5 (Note 7)	V
		0 to V _{CCB} (Note 8)	
	V _{I/OA}	0 to 5.5 (Note 7)	
		0 to V _{CCA} (Note 8)	
Output current	I _{OUTB}	± 24 (Note 9)	mA
		± 8 (Note 10)	
	I _{OUTA}	± 24 (Note 11)	
Operating temperature	T _{opr}	-40 to 85	°C
Input rise and fall time	dt/dv	0 to 10 (Note 12)	ns/V

Note 7: Output in OFF state

Note 8: High or low state

Note 9: V_{CCB} = 3.0 to 3.6 V

Note 10: V_{CCB} = 2.3 to 2.7 V

Note 11: V_{CCA} = 4.5 to 5.5 V

Note 12: V_{INB} = 0.8 to 2.0 V, V_{CCB} = 3.0 V
V_{INA} = 0.8 to 2.0 V, V_{CCA} = 5.0 V

Electrical Characteristics**DC Characteristics**

Characteristics	Symbol	Test Condition	V _{CCB} (V)	V _{CCA} (V)	Ta = -40 to 85°C		Unit
					Min	Max	
"H" level input voltage	V _{IHB}	DIR, \overline{OE} , Bn	2.5 ± 0.2	5.0 ± 0.5	1.7	—	V
			3.3 ± 0.3	5.0 ± 0.5	2.0	—	
	V _{IHA}	An	2.3 to 3.6	5.0 ± 0.5	2.0	—	
"L" level input voltage	V _{ILB}	DIR, \overline{OE} , Bn	2.5 ± 0.2	5.0 ± 0.5	—	0.7	V
			3.3 ± 0.3	5.0 ± 0.5	—	0.8	
	V _{ILA}	An	2.3 to 3.6	5.0 ± 0.5	—	0.8	
"H" level output voltage	V _{OHB}	V _{INA} = V _{IHA} or V _{ILA}	I _{OHB} = -100 μA	2.3 to 3.6	5.0 ± 0.5	V _{CCB} - 0.2	V
			I _{OHB} = -24 mA	3.0	5.0 ± 0.5	2.2	
			I _{OHB} = -8mA	2.3	5.0 ± 0.5	1.8	
	V _{OHA}	V _{INB} = V _{IHB} or V _{ILB}	I _{OHA} = -100 μA	2.3 to 3.6	5.0 ± 0.5	V _{CCA} - 0.2	
			I _{OHA} = -24 mA	2.3 to 3.6	4.5	3.8	
"L" level output voltage	V _{OLB}	V _{INA} = V _{IHA} or V _{ILA}	I _{OLB} = 100 μA	2.3 to 3.6	5.0 ± 0.5	—	V
			I _{OLB} = 24 mA	3.0	5.0 ± 0.5	—	
			I _{OLB} = 8 mA	2.3	5.0 ± 0.5	—	
	V _{OLA}	V _{INB} = V _{IHB} or V _{ILB}	I _{OLA} = 100 μA	2.3 to 3.6	5.0 ± 0.5	—	
			I _{OLA} = 24 mA	2.3 to 3.6	4.5	—	
3-state output off-state current	I _{OZB}	V _{IN} = V _{IHB} or V _{ILB} V _{I/OB} = V _{CCB} or GND		2.3 to 3.6	5.0 ± 0.5	—	μA
	I _{OZA}	V _{IN} = V _{IHB} or V _{ILB} V _{I/OA} = V _{CCA} or GND		2.3 to 3.6	5.0 ± 0.5	—	
Input leakage current	I _{IN}	V _{IN} (DIR, \overline{OE}) = V _{CCB} or GND		3.6	5.5	—	±5.0
Power off leakage current	I _{OFF}	V _{INA} /V _{INB} = 0 to 5.5 V		0	0	—	10
Quiescent supply current	I _{CCB1}	V _{I/OA} = Open, V _{CCA} = Open V _{INB} = V _{CCB} or GND \overline{OE} = V _{CCB} , DIR = GND		3.6	Open	—	50
	I _{CCB2}	V _{INA} = V _{CCA} or GND V _{INB} = V _{CCB} or GND		3.6	5.5	—	50
	I _{CCA}	V _{INA} = V _{CCA} or GND V _{INB} = V _{CCB} or GND		3.6	5.5	—	80
	I _{CCTB}	V _{INB} = V _{CCB} - 0.6 V per input		3.6	5.0 ± 0.5	—	500
	I _{CCTA}	V _{INA} = 3.4 V per input		2.3 to 3.6	5.5	—	2.0
							mA

AC Characteristics (input: $t_r = t_f = 2.5 \text{ ns}$, $R_L = 500 \Omega$) $V_{CCB} = 3.3 \pm 0.3 \text{ V}$

Characteristics	Symbol	Test Condition	CL (pF)	V _{CCA} (V)	Ta = -40 to 85°C		Unit
					Min	Max	
Propagation delay time (Bn → An)	t_{pLH} t_{pHL}	Input: Bn Output: An (DIR = "L")	50	5.0 ± 0.5	1.0	6.0	ns
3-state output enable time ($\overline{OE} \rightarrow An$)	t_{pZL} t_{pZH}		50	5.0 ± 0.5	1.0	9.0	
3-state output disable time ($\overline{OE} \rightarrow An$)	t_{pLZ} t_{pHZ}		50	5.0 ± 0.5	1.0	9.0	
Propagation delay time (An → Bn)	t_{pLH} t_{pHL}	Input: An Output: Bn (DIR = "H")	50	5.0 ± 0.5	1.0	7.0	ns
3-state output enable time ($OE \rightarrow Bn$)	t_{pZL} t_{pZH}		50	5.0 ± 0.5	1.0	9.0	
3-state output disable time ($OE \rightarrow Bn$)	t_{pLZ} t_{pHZ}		50	5.0 ± 0.5	1.0	9.0	
Output to output skew	t_{osLH} t_{osHL}	(Note 13)	50	5.0 ± 0.5	—	1.0	ns

Note 13: Parameter guaranteed by design.

$$(tosLH = |t_{pLHm} - t_{pLHn}|, tosHL = |t_{pHLm} - t_{pHLn}|)$$

 $V_{CCB} = 2.5 \pm 0.2 \text{ V}$

Characteristics	Symbol	Test Condition	CL (pF)	V _{CCA} (V)	Ta = -40 to 85°C		Unit
					Min	Max	
Propagation delay time (Bn → An)	t_{pLH} t_{pHL}	Input: Bn Output: An (DIR = "L")	50	5.0 ± 0.5	1.0	8.0	ns
3-state output enable time ($\overline{OE} \rightarrow An$)	t_{pZL} t_{pZH}		50	5.0 ± 0.5	1.0	12.0	
3-state output disable time ($\overline{OE} \rightarrow An$)	t_{pLZ} t_{pHZ}		50	5.0 ± 0.5	1.0	12.0	
Propagation delay time (An → Bn)	t_{pLH} t_{pHL}	Input: An Output: Bn (DIR = "H")	30	5.0 ± 0.5	1.0	9.0	ns
3-state output enable time ($OE \rightarrow Bn$)	t_{pZL} t_{pZH}		30	5.0 ± 0.5	1.0	12.0	
3-state output disable time ($OE \rightarrow Bn$)	t_{pLZ} t_{pHZ}		30	5.0 ± 0.5	1.0	10.0	
Output to output skew	t_{osLH} t_{osHL}	(Note 13)	30 or 50	5.0 ± 0.5	—	1.0	ns

Note 13: Parameter guaranteed by design.

$$(tosLH = |t_{pLHm} - t_{pLHn}|, tosHL = |t_{pHLm} - t_{pHLn}|)$$

Capacitive Characteristics (Ta = 25°C)**V_{CCB} = 2.5, 3.3 V**

Characteristics	Symbol	Test Circuit	Test Condition	V _{CCA} (V)	Typ.	Unit
Input capacitance	C _{IN}	—	DIR, OE	5.0	7	pF
Output capacitance	C _{I/O}	—	An, Bn	5.0	8	pF
Power dissipation capacitance (Note 14)	C _{PDA}	—	A ⇒ B (DIR = "H")	5.0	20	pF
			B ⇒ A (DIR = "L")	5.0	66	
	C _{PDB}	—	A ⇒ B (DIR = "H")	5.0	34	
			B ⇒ A (DIR = "L")	5.0	4	

Note 14: CPD is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

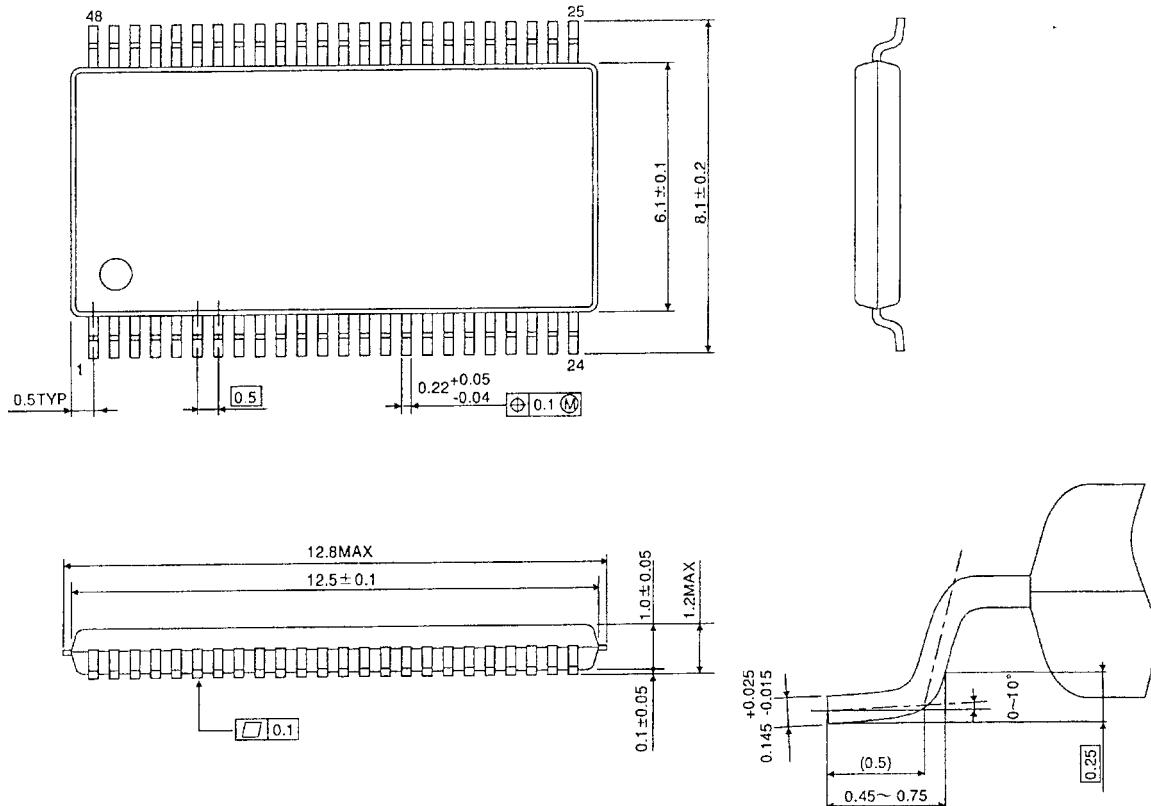
Average operating current can be obtained by the equation:

$$I_{CC}(\text{opr}) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/16 \text{ (per bit)}$$

Package Dimensions

TSSOP48-P-0061-0.50

Unit : mm



Weight: 0.25 g (typ.)

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